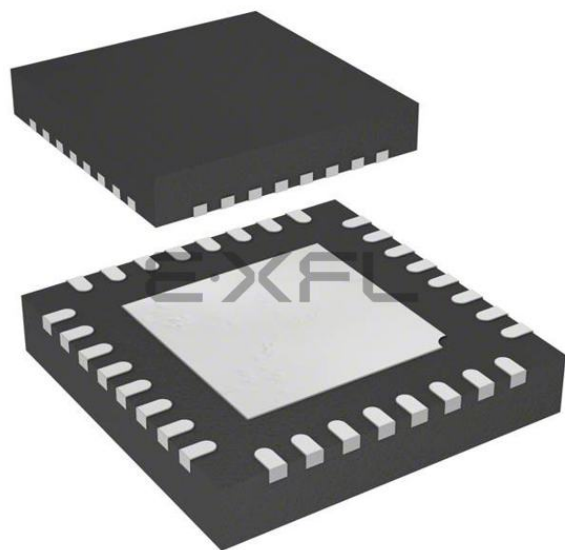




Welcome to [E-XFL.COM](https://www.e-xfl.com)

What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	32MHz
Connectivity	I ² C, IrDA, LINbus, SPI, UART/USART, USB
Peripherals	Brown-out Detect/Reset, DMA, I ² S, LCD, POR, PWM, WDT
Number of I/O	23
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	6K x 8
RAM Size	20K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 10x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	32-UFQFN Exposed Pad
Supplier Device Package	32-UFQFPN (5x5)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm32l082kbu6

Contents

1	Introduction	9
2	Description	10
2.1	Device overview	11
2.2	Ultra-low-power device continuum	13
3	Functional overview	14
3.1	Low-power modes	14
3.2	Interconnect matrix	19
3.3	ARM® Cortex®-M0+ core with MPU	20
3.4	Reset and supply management	21
3.4.1	Power supply schemes	21
3.4.2	Power supply supervisor	21
3.4.3	Voltage regulator	22
3.5	Clock management	22
3.6	Low-power real-time clock and backup registers	25
3.7	General-purpose inputs/outputs (GPIOs)	25
3.8	Memories	26
3.9	Boot modes	26
3.10	Direct memory access (DMA)	27
3.11	Analog-to-digital converter (ADC)	27
3.12	Temperature sensor	27
3.12.1	Internal voltage reference (V_{REFINT})	28
3.13	Digital-to-analog converter (DAC)	28
3.14	Ultra-low-power comparators and reference voltage	29
3.15	Touch sensing controller (TSC)	29
3.16	AES	30
3.17	Timers and watchdogs	31
3.17.1	General-purpose timers (TIM2, TIM3, TIM21 and TIM22)	31
3.17.2	Low-power Timer (LPTIM)	32
3.17.3	Basic timer (TIM6, TIM7)	32
3.17.4	SysTick timer	32

6.3.11	Electrical sensitivity characteristics	82
6.3.12	I/O current injection characteristics	83
6.3.13	I/O port characteristics	84
6.3.14	NRST pin characteristics	88
6.3.15	12-bit ADC characteristics	89
6.3.16	DAC electrical specifications	95
6.3.17	Temperature sensor characteristics	97
6.3.18	Comparators	98
6.3.19	Timer characteristics	99
6.3.20	Communications interfaces	99
7	Package information	107
7.1	WLCSP49 package information	108
7.2	LQFP32 package information	111
7.3	UFQFPN32 package information	113
7.4	Thermal characteristics	115
7.4.1	Reference document	116
8	Part numbering	117
9	Revision history	118

List of figures

Figure 1.	STM32L082xx block diagram	12
Figure 2.	Clock tree	24
Figure 3.	STM32L082xx WLCSP49 ballout	37
Figure 4.	STM32L082xx LQFP32 pinout	37
Figure 5.	STM32L082xx UFQFPN32 pinout	38
Figure 6.	Memory map	47
Figure 7.	Pin loading conditions	48
Figure 8.	Pin input voltage	48
Figure 9.	Power supply scheme	49
Figure 10.	Current consumption measurement scheme	49
Figure 11.	IDD vs VDD, at TA= 25/55/85/105 °C, Run mode, code running from Flash memory, Range 2, HSE, 1WS	58
Figure 12.	IDD vs VDD, at TA= 25/55/85/105 °C, Run mode, code running from Flash memory, Range 2, HSI16, 1WS	59
Figure 13.	IDD vs VDD, at TA= 25 °C, Low-power run mode, code running from RAM, Range 3, MSI (Range 0) at 64 KHz, 0 WS	63
Figure 14.	IDD vs VDD, at TA= 25/55/ 85/105/125 °C, Stop mode with RTC enabled and running on LSE Low drive	64
Figure 15.	IDD vs VDD, at TA= 25/55/85/105/125 °C, Stop mode with RTC disabled, all clocks off	65
Figure 16.	High-speed external clock source AC timing diagram	71
Figure 17.	Low-speed external clock source AC timing diagram	72
Figure 18.	HSE oscillator circuit diagram	73
Figure 19.	Typical application with a 32.768 kHz crystal	74
Figure 20.	HSI16 minimum and maximum value versus temperature	75
Figure 21.	VIH/VIL versus VDD (CMOS I/Os)	85
Figure 22.	VIH/VIL versus VDD (TTL I/Os)	85
Figure 23.	I/O AC characteristics definition	88
Figure 24.	Recommended NRST pin protection	89
Figure 25.	ADC accuracy characteristics	92
Figure 26.	Typical connection diagram using the ADC	93
Figure 27.	Power supply and reference decoupling (V_{REF+} not connected to V_{DDA})	93
Figure 28.	Power supply and reference decoupling (V_{REF+} connected to V_{DDA})	94
Figure 29.	12-bit buffered/non-buffered DAC	97
Figure 30.	SPI timing diagram - slave mode and CPHA = 0	103
Figure 31.	SPI timing diagram - slave mode and CPHA = 1 ⁽¹⁾	104
Figure 32.	SPI timing diagram - master mode ⁽¹⁾	104
Figure 33.	USB timings: definition of data signal rise and fall time	106
Figure 34.	WLCSP49 - 49-pin, 3.294 x 3.258 mm, 0.4 mm pitch wafer level chip scale package outline	108
Figure 35.	WLCSP49 - 49-pin, 3.294 x 3.258 mm, 0.4 mm pitch wafer level chip scale recommended footprint	109
Figure 36.	LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat package outline	111
Figure 37.	LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat recommended footprint	112
Figure 38.	UFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch ultra thin fine pitch quad flat package outline	113
Figure 39.	UFQFPN32 - 32-pin, 5x5 mm, 0.5 mm pitch ultra thin fine pitch quad flat recommended footprint	114

1 Introduction

The ultra-low-power STM32L082xx are offered in 32- and 49-pin packages. Depending on the device chosen, different sets of peripherals are included, the description below gives an overview of the complete range of peripherals proposed in this family.

These features make the ultra-low-power STM32L082xx microcontrollers suitable for a wide range of applications:

- Gas/water meters and industrial sensors
- Healthcare and fitness equipment
- Remote control and user interface
- PC peripherals, gaming, GPS equipment
- Alarm system, wired and wireless sensors, video intercom

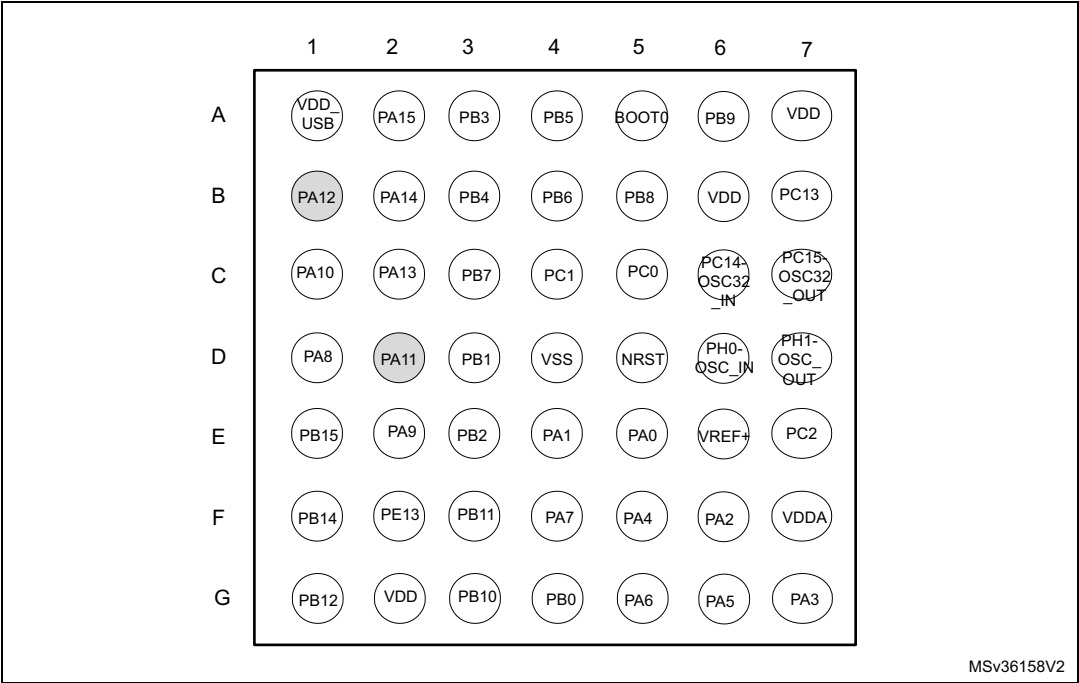
This STM32L082xx datasheet should be read in conjunction with the STM32L0x2xx reference manual (RM0376).

For information on the ARM® Cortex®-M0+ core please refer to the Cortex®-M0+ Technical Reference Manual, available from the www.arm.com website.

Figure 1 shows the general block diagram of the device family.

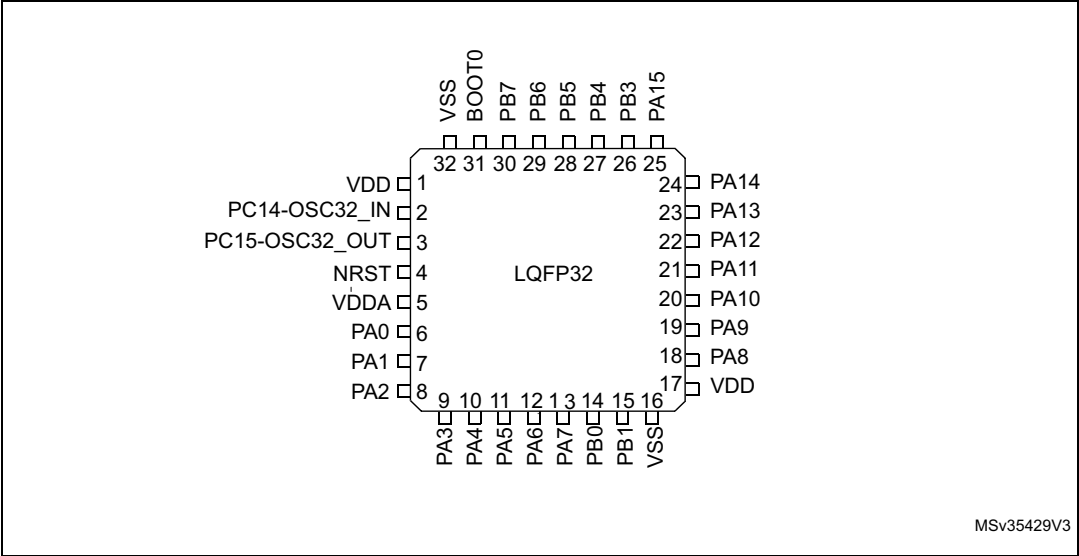
4 Pin descriptions

Figure 3. STM32L082xx WLCSP49 ballout



1. The above figure shows the package top view.
2. I/O pin supplied by VDD_USB.

Figure 4. STM32L082xx LQFP32 pinout



1. The above figure shows the package top view.

6.3 Operating conditions

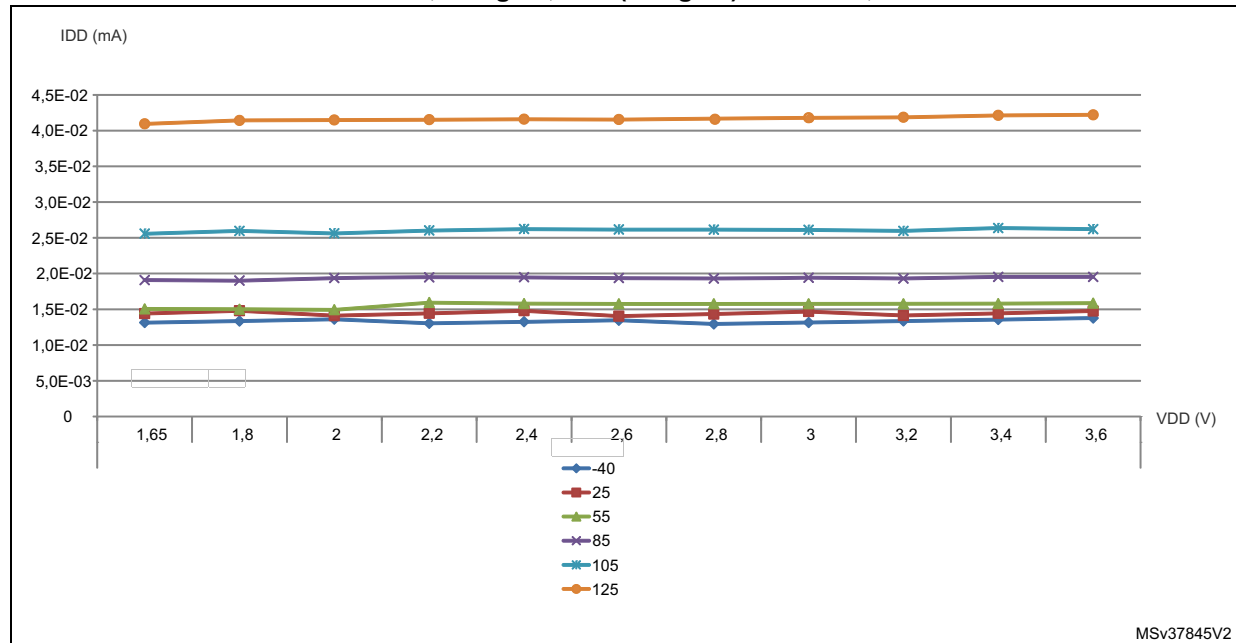
6.3.1 General operating conditions

Table 23. General operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
f _{HCLK}	Internal AHB clock frequency	-	0	32	MHz
f _{PCLK1}	Internal APB1 clock frequency	-	0	32	
f _{PCLK2}	Internal APB2 clock frequency	-	0	32	
V _{DD}	Standard operating voltage	BOR detector disabled	1.65	3.6	V
		BOR detector enabled, at power on	1.8	3.6	
		BOR detector disabled, after power on	1.65	3.6	
V _{DDA}	Analog operating voltage (DAC not used)	Must be the same voltage as V _{DD} ⁽¹⁾	1.65	3.6	V
V _{DDA}	Analog operating voltage (all features)	Must be the same voltage as V _{DD} ⁽¹⁾	1.8	3.6	V
V _{DD_USB} B	Standard operating voltage, USB domain ⁽²⁾	USB peripheral used	3.0	3.6	V
		USB peripheral not used	1.65	3.6	
V _{IN}	Input voltage on FT, FTf and RST pins ⁽³⁾	2.0 V ≤ V _{DD} ≤ 3.6 V	-0.3	5.5	V
		1.65 V ≤ V _{DD} ≤ 2.0 V	-0.3	5.2	
	Input voltage on BOOT0 pin	-	0	5.5	
	Input voltage on TC pin	-	-0.3	V _{DD} +0.3	
P _D	Power dissipation at T _A = 85 °C (range 6) or T _A = 105 °C (range 7) ⁽⁴⁾	WLCSP49 package	-	417	mW
		UFQFPN32 package	-	556	
		LQFP32 package	-	333	
		WLCSP49 package	-	104	
		UFQFPN32 package	-	139	
		LQFP32 package	-	83	
T _A	Temperature range	Maximum power dissipation (range 6)	-40	85	°C
		Maximum power dissipation (range 7)	-40	105	
		Maximum power dissipation (range 3)	-40	125	
T _J	Junction temperature range (range 6)	-40 °C ≤ T _A ≤ 85 °	-40	105	
	Junction temperature range (range 7)	-40 °C ≤ T _A ≤ 105 °C	-40	125	
	Junction temperature range (range 3)	-40 °C ≤ T _A ≤ 125 °C	-40	130	

1. It is recommended to power V_{DD} and V_{DDA} from the same source. A maximum difference of 300 mV between V_{DD} and V_{DDA} can be tolerated during power-up and normal operation.

Figure 13. I_{DD} vs V_{DD} , at $T_A = 25\text{ °C}$, Low-power run mode, code running from RAM, Range 3, MSI (Range 0) at 64 KHz, 0 WS



MSv37845V2

Table 33. Current consumption in Low-power sleep mode

Symbol	Parameter	Condition			Typ	Max (1)	Unit
I_{DD} (LP Sleep)	Supply current in Low-power sleep mode	All peripherals OFF, code executed from Flash memory, V_{DD} from 1.65 to 3.6 V	MSI clock = 65 kHz, $f_{HCLK} = 32$ kHz, Flash memory OFF	$T_A = -40$ to 25 °C	4,7	-	μA
			MSI clock = 65 kHz, $f_{HCLK} = 32$ kHz	$T_A = -40$ to 25 °C	17	24	
				$T_A = 85\text{ °C}$	19,5	30	
				$T_A = 105\text{ °C}$	23	47	
				$T_A = 125\text{ °C}$	32,5	70	
			MSI clock = 65 kHz, $f_{HCLK} = 65$ kHz	$T_A = -40$ to 25 °C	17	24	
				$T_A = 85\text{ °C}$	20	31	
				$T_A = 105\text{ °C}$	23,5	47	
				$T_A = 125\text{ °C}$	32,5	70	
			MSI clock = 131kHz, $f_{HCLK} = 131$ kHz	$T_A = -40$ to 25 °C	19,5	27	
				$T_A = 55\text{ °C}$	20,5	28	
				$T_A = 85\text{ °C}$	22,5	33	
				$T_A = 105\text{ °C}$	26	50	
				$T_A = 125\text{ °C}$	35	73	

1. Guaranteed by characterization results at 125 °C , unless otherwise specified.

Table 34. Typical and maximum current consumptions in Stop mode

Symbol	Parameter	Conditions	Typ	Max ⁽¹⁾	Unit
I_{DD} (Stop)	Supply current in Stop mode	$T_A = -40$ to 25°C	0,43	1,00	μA
		$T_A = 55^\circ\text{C}$	0,735	2,50	
		$T_A = 85^\circ\text{C}$	2,25	4,90	
		$T_A = 105^\circ\text{C}$	5,3	13,00	
		$T_A = 125^\circ\text{C}$	12,5	28,00	

1. Guaranteed by characterization results at 125°C , unless otherwise specified.

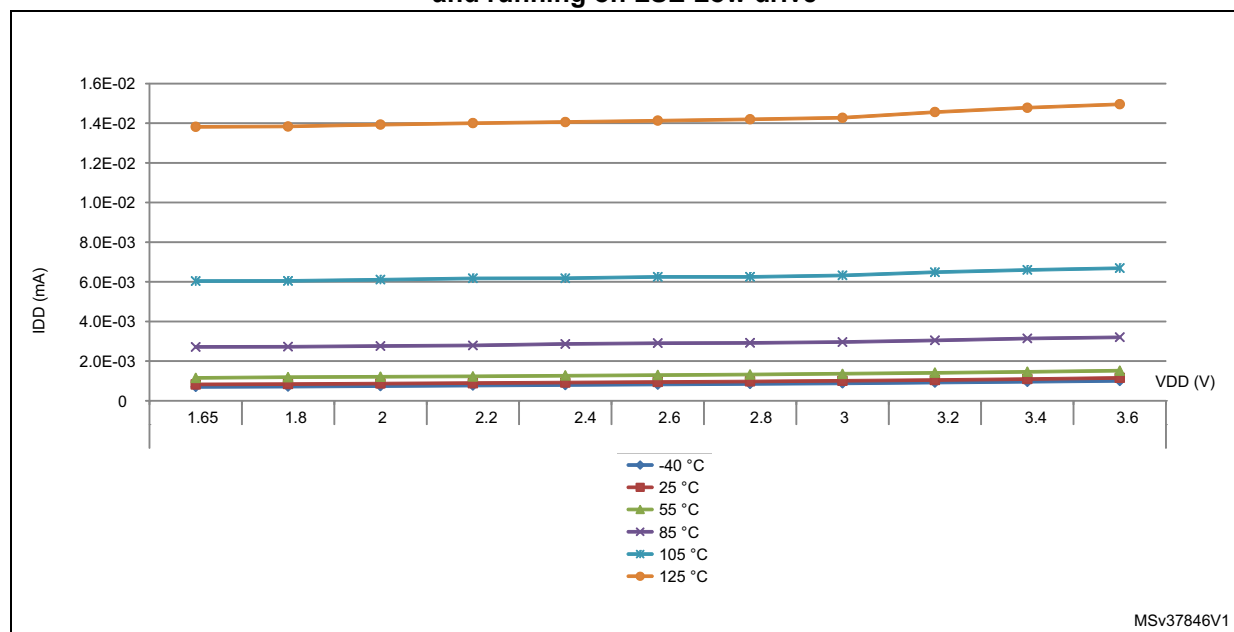
Figure 14. I_{DD} vs V_{DD} , at $T_A = 25/55/ 85/105/125^\circ\text{C}$, Stop mode with RTC enabled and running on LSE Low drive

Figure 15. I_{DD} vs V_{DD} , at $T_A = 25/55/85/105/125\text{ }^{\circ}\text{C}$, Stop mode with RTC disabled, all clocks off

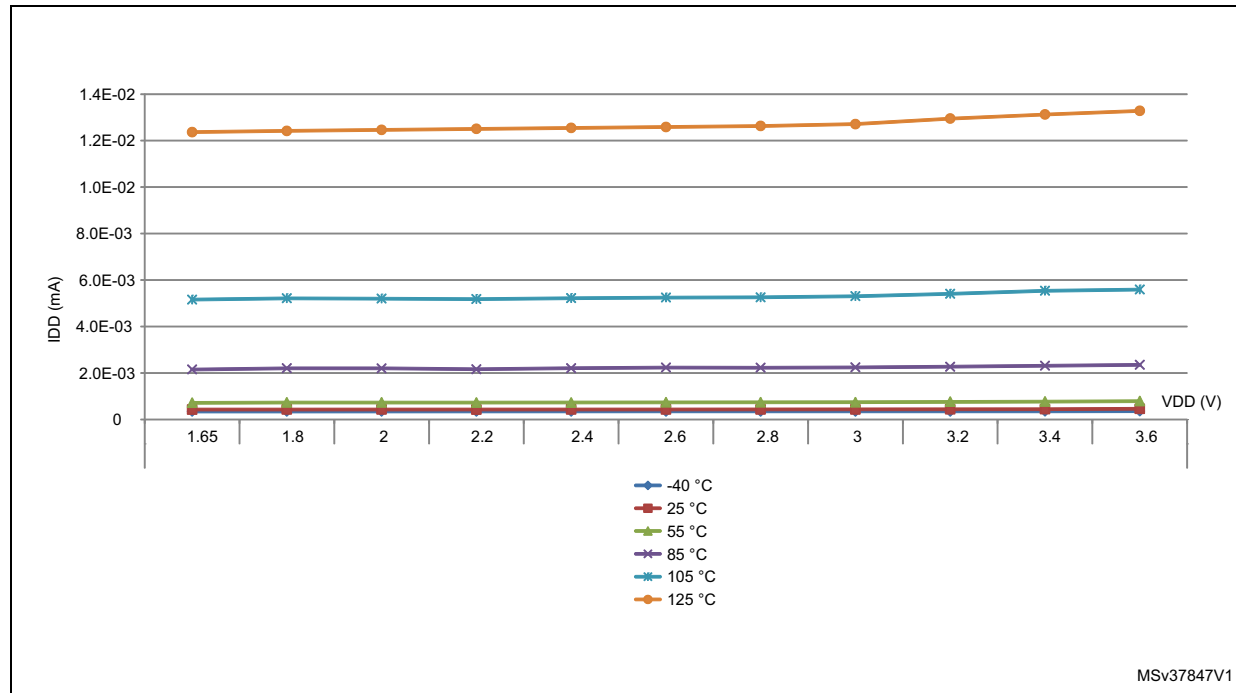


Table 35. Typical and maximum current consumptions in Standby mode

Symbol	Parameter	Conditions		Typ	Max ⁽¹⁾	Unit
I_{DD} (Standby)	Supply current in Standby mode	Independent watchdog and LSI enabled	$T_A = -40\text{ to }25\text{ }^{\circ}\text{C}$	0,855	1,70	μA
			$T_A = 55\text{ }^{\circ}\text{C}$	-	2,90	
			$T_A = 85\text{ }^{\circ}\text{C}$	-	3,30	
			$T_A = 105\text{ }^{\circ}\text{C}$	-	4,10	
			$T_A = 125\text{ }^{\circ}\text{C}$	-	8,50	
		Independent watchdog and LSI off	$T_A = -40\text{ to }25\text{ }^{\circ}\text{C}$	0,29	0,60	
			$T_A = 55\text{ }^{\circ}\text{C}$	0,32	1,20	
			$T_A = 85\text{ }^{\circ}\text{C}$	0,5	2,30	
			$T_A = 105\text{ }^{\circ}\text{C}$	0,94	3,00	
			$T_A = 125\text{ }^{\circ}\text{C}$	2,6	7,00	

1. Guaranteed by characterization results at $125\text{ }^{\circ}\text{C}$, unless otherwise specified

Table 36. Average current consumption during Wakeup

Symbol	parameter	System frequency	Current consumption during wakeup	Unit
I_{DD} (Wakeup from Stop)	Supply current during Wakeup from Stop mode	HSI	1	mA
		HSI/4	0,7	
		MSI clock = 4,2 MHz	0,7	
		MSI clock = 1,05 MHz	0,4	
		MSI clock = 65 KHz	0,1	
I_{DD} (Reset)	Reset pin pulled down	-	0,21	
I_{DD} (Power-up)	BOR on	-	0,23	
I_{DD} (Wakeup from StandBy)	With Fast wakeup set	MSI clock = 2,1 MHz	0,5	
	With Fast wakeup disabled	MSI clock = 2,1 MHz	0,12	

Low-speed external user clock generated from an external source

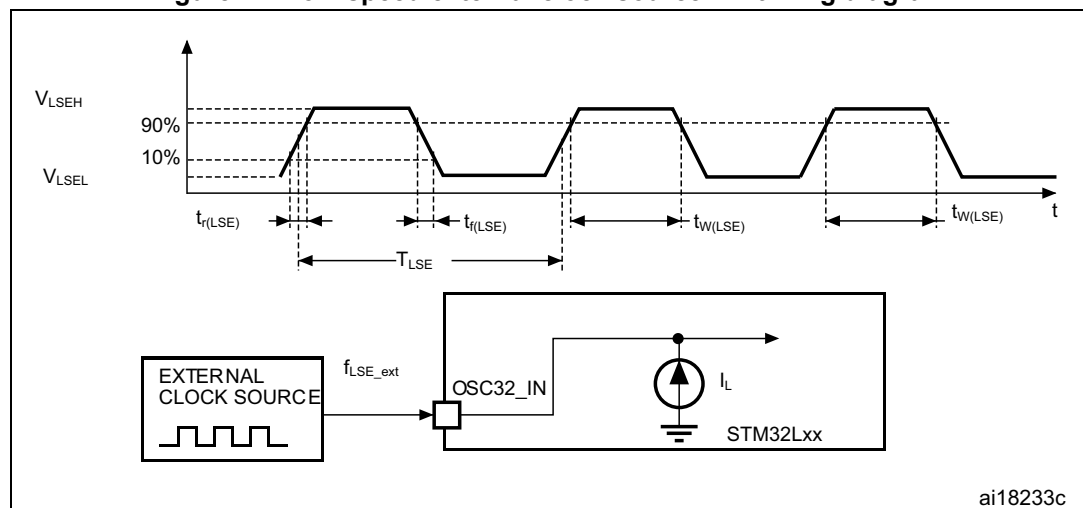
The characteristics given in the following table result from tests performed using a low-speed external clock source, and under ambient temperature and supply voltage conditions summarized in [Table 23](#).

Table 41. Low-speed external user clock characteristics⁽¹⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{LSE_ext}	User external clock source frequency	-	1	32.768	1000	kHz
V_{LSEH}	OSC32_IN input pin high level voltage		$0.7V_{DD}$	-	V_{DD}	V
V_{LSEL}	OSC32_IN input pin low level voltage		V_{SS}	-	$0.3V_{DD}$	
$t_{w(LSE)}$ $t_{w(LSE)}$	OSC32_IN high or low time		465	-	-	ns
$t_{r(LSE)}$ $t_{f(LSE)}$	OSC32_IN rise or fall time		-	-	10	
$C_{IN(LSE)}$	OSC32_IN input capacitance	-	-	0.6	-	pF
$DuCy_{(LSE)}$	Duty cycle	-	45	-	55	%
I_L	OSC32_IN Input leakage current	$V_{SS} \leq V_{IN} \leq V_{DD}$	-	-	± 1	μA

1. Guaranteed by design, not tested in production

Figure 17. Low-speed external clock source AC timing diagram



High-speed internal 48 MHz (HSI48) RC oscillator**Table 45. HSI48 oscillator characteristics⁽¹⁾**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{HSI48}	Frequency		-	48	-	MHz
TRIM	HSI48 user-trimming step		0.09 ⁽²⁾	0.14	0.2 ⁽²⁾	%
DuCy _(HSI48)	Duty cycle		45 ⁽²⁾	-	55 ⁽²⁾	%
ACC _{HSI48}	Accuracy of the HSI48 oscillator (factory calibrated before CRS calibration)	$T_A = 25\text{ °C}$	-4 ⁽³⁾	-	4 ⁽³⁾	%
$t_{\text{su}}(\text{HSI48})$	HSI48 oscillator startup time		-	-	6 ⁽²⁾	μs
$I_{\text{DDA}}(\text{HSI48})$	HSI48 oscillator power consumption		-	330	380 ⁽²⁾	μA

1. $V_{\text{DDA}} = 3.3\text{ V}$, $T_A = -40$ to 125 °C unless otherwise specified.

2. Guaranteed by design.

3. Guaranteed by characterization results.

Low-speed internal (LSI) RC oscillator**Table 46. LSI oscillator characteristics**

Symbol	Parameter	Min	Typ	Max	Unit
$f_{\text{LSI}}^{(1)}$	LSI frequency	26	38	56	kHz
$D_{\text{LSI}}^{(2)}$	LSI oscillator frequency drift $0\text{ °C} \leq T_A \leq 85\text{ °C}$	-10	-	4	%
$t_{\text{su}}(\text{LSI})^{(3)}$	LSI oscillator startup time	-	-	200	μs
$I_{\text{DD}}(\text{LSI})^{(3)}$	LSI oscillator power consumption	-	400	510	nA

1. Guaranteed by test in production.

2. This is a deviation for an individual part, once the initial frequency has been measured.

3. Guaranteed by design.

Multi-speed internal (MSI) RC oscillator**Table 47. MSI oscillator characteristics**

Symbol	Parameter	Condition	Typ	Max	Unit
f_{MSI}	Frequency after factory calibration, done at $V_{\text{DD}} = 3.3\text{ V}$ and $T_A = 25\text{ °C}$	MSI range 0	65.5	-	kHz
		MSI range 1	131	-	
		MSI range 2	262	-	
		MSI range 3	524	-	
		MSI range 4	1.05	-	MHz
		MSI range 5	2.1	-	
		MSI range 6	4.2	-	

6.3.13 I/O port characteristics

General input/output characteristics

Unless otherwise specified, the parameters given in [Table 57](#) are derived from tests performed under the conditions summarized in [Table 23](#). All I/Os are CMOS and TTL compliant.

Table 57. I/O static characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{IL}	Input low level voltage	TC, FT, FTf, RST I/Os	-	-	$0.3V_{DD}$	V
		BOOT0 pin	-	-	$0.14V_{DD}^{(1)}$	
V_{IH}	Input high level voltage	All I/Os	$0.7 V_{DD}$	-	-	
V_{hys}	I/O Schmitt trigger voltage hysteresis ⁽²⁾	Standard I/Os	-	$10\% V_{DD}^{(3)}$	-	
		BOOT0 pin	-	0.01	-	
I_{lkg}	Input leakage current ⁽⁴⁾	$V_{SS} \leq V_{IN} \leq V_{DD}$ All I/Os except for PA11, PA12, BOOT0 and FTf I/Os	-	-	± 50	nA
		$V_{SS} \leq V_{IN} \leq V_{DD}$, PA11 and PA12 I/Os	-	-	-50/+250	
		$V_{SS} \leq V_{IN} \leq V_{DD}$ FTf I/Os	-	-	± 100	
		$V_{DD} \leq V_{IN} \leq 5 V$ All I/Os except for PA11, PA12, BOOT0 and FTf I/Os	-	-	200	nA
		$V_{DD} \leq V_{IN} \leq 5 V$ FTf I/Os	-	-	500	
		$V_{DD} \leq V_{IN} \leq 5 V$ PA11, PA12 and BOOT0	-	-	10	μA
R_{PU}	Weak pull-up equivalent resistor ⁽⁵⁾	$V_{IN} = V_{SS}$	30	45	60	k Ω
R_{PD}	Weak pull-down equivalent resistor ⁽⁵⁾	$V_{IN} = V_{DD}$	30	45	60	k Ω
C_{IO}	I/O pin capacitance	-	-	5	-	pF

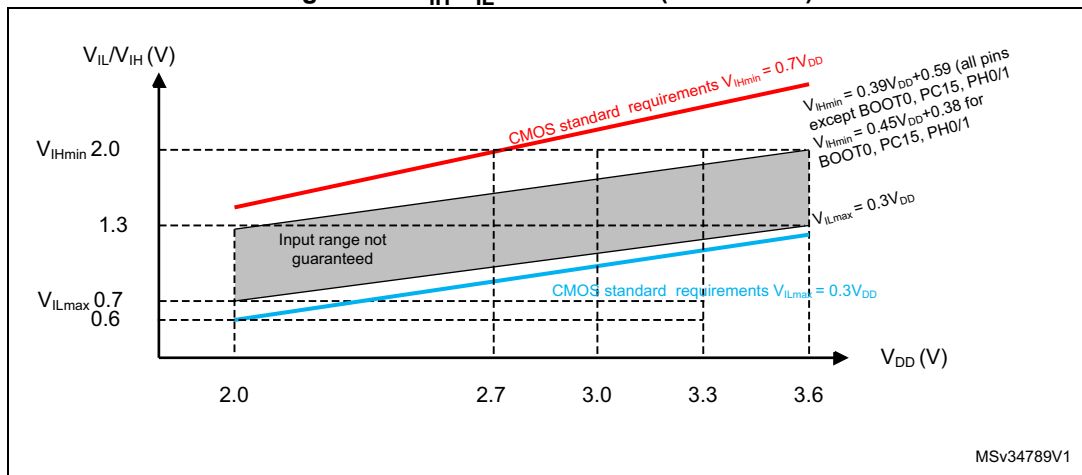
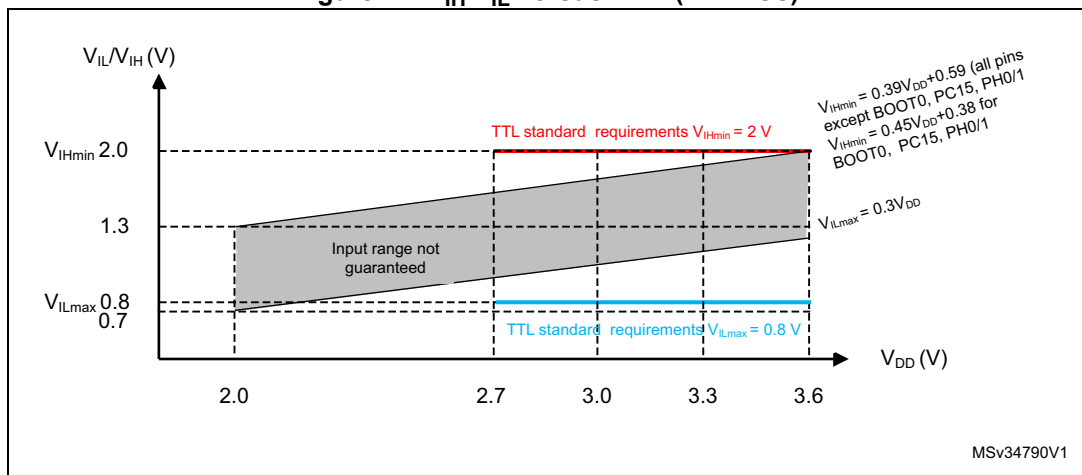
1. Guaranteed by characterization.

2. Hysteresis voltage between Schmitt trigger switching levels. Guaranteed by characterization results.

3. With a minimum of 200 mV. Guaranteed by characterization results.

4. The max. value may be exceeded if negative current is injected on adjacent pins.

5. Pull-up and pull-down resistors are designed with a true resistance in series with a switchable PMOS/NMOS. This MOS/NMOS contribution to the series resistance is minimum (~10% order).

Figure 21. V_{IH}/V_{IL} versus V_{DD} (CMOS I/Os)Figure 22. V_{IH}/V_{IL} versus V_{DD} (TTL I/Os)

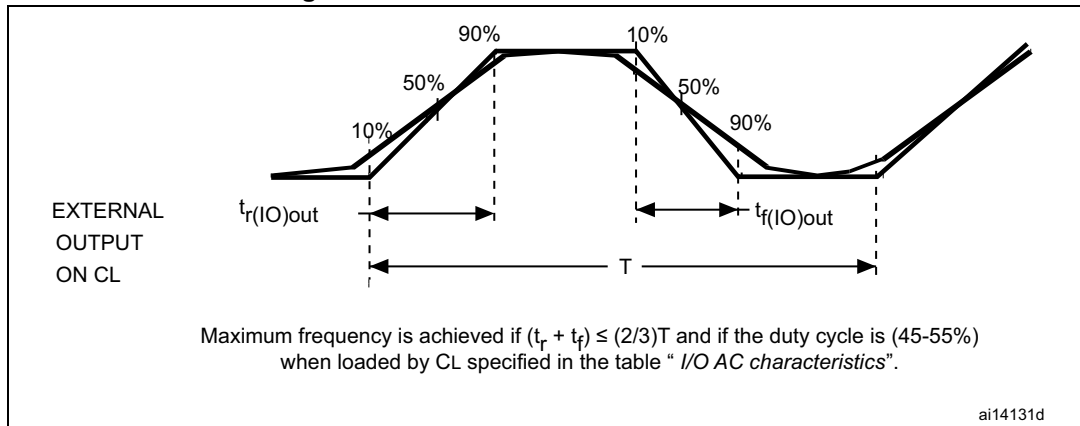
Output driving current

The GPIOs (general purpose input/outputs) can sink or source up to ± 8 mA, and sink or source up to ± 15 mA with the non-standard V_{OL}/V_{OH} specifications given in [Table 58](#).

In the user application, the number of I/O pins which can drive current must be limited to respect the absolute maximum rating specified in [Section 6.2](#):

- The sum of the currents sourced by all the I/Os on V_{DD} , plus the maximum Run consumption of the MCU sourced on V_{DD} , cannot exceed the absolute maximum rating $I_{VDD(\Sigma)}$ (see [Table 21](#)).
- The sum of the currents sunk by all the I/Os on V_{SS} plus the maximum Run consumption of the MCU sunk on V_{SS} cannot exceed the absolute maximum rating $I_{VSS(\Sigma)}$ (see [Table 21](#)).

Figure 23. I/O AC characteristics definition



6.3.14 NRST pin characteristics

The NRST pin input driver uses CMOS technology. It is connected to a permanent pull-up resistor, R_{PU} , except when it is internally driven low (see [Table 60](#)).

Unless otherwise specified, the parameters given in [Table 60](#) are derived from tests performed under ambient temperature and V_{DD} supply voltage conditions summarized in [Table 23](#).

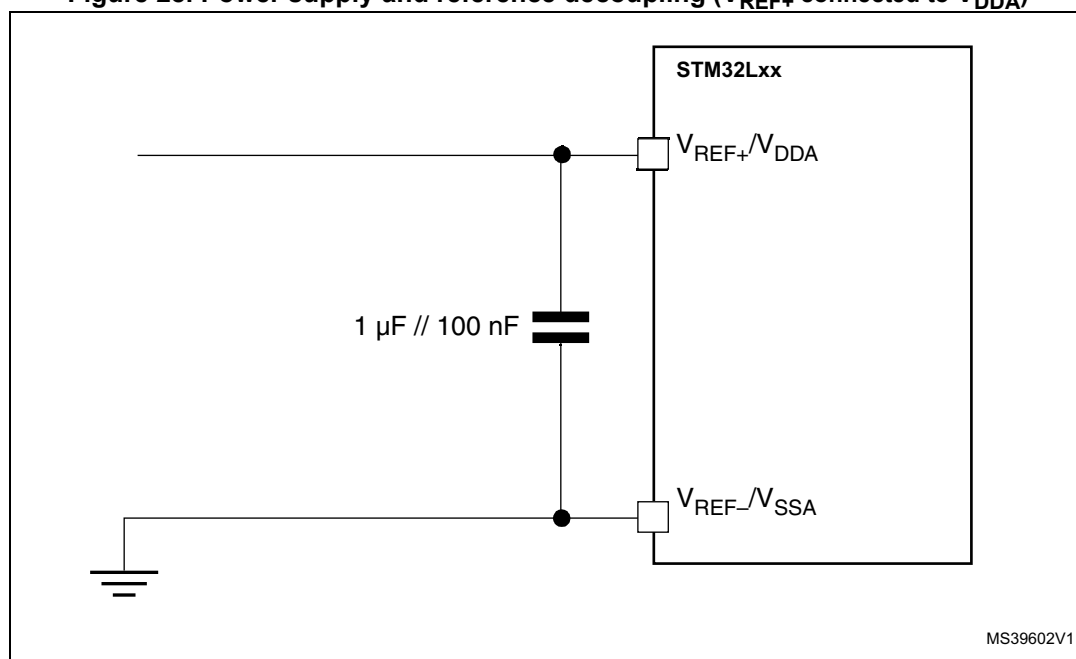
Table 60. NRST pin characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IL(NRST)}^{(1)}$	NRST input low level voltage	-	V_{SS}	-	0.8	V
$V_{IH(NRST)}^{(1)}$	NRST input high level voltage	-	1.4	-	V_{DD}	
$V_{OL(NRST)}^{(1)}$	NRST output low level voltage	$I_{OL} = 2 \text{ mA}$ $2.7 \text{ V} < V_{DD} < 3.6 \text{ V}$	-	-	0.4	
		$I_{OL} = 1.5 \text{ mA}$ $1.65 \text{ V} < V_{DD} < 2.7 \text{ V}$	-	-		
$V_{hys(NRST)}^{(1)}$	NRST Schmitt trigger voltage hysteresis	-	-	$10\%V_{DD}^{(2)}$	-	mV
R_{PU}	Weak pull-up equivalent resistor ⁽³⁾	$V_{IN} = V_{SS}$	30	45	60	kΩ
$V_{F(NRST)}^{(1)}$	NRST input filtered pulse	-	-	-	50	ns
$V_{NF(NRST)}^{(1)}$	NRST input not filtered pulse	-	350	-	-	ns

1. Guaranteed by design.

2. 200 mV minimum value

3. The pull-up is designed with a true resistance in series with a switchable PMOS. This PMOS contribution to the series resistance is around 10%.

Figure 28. Power supply and reference decoupling (V_{REF+} connected to V_{DDA})

The analog spike filter is compliant with I²C timings requirements only for the following voltage ranges:

- Fast mode Plus: $2.7\text{ V} \leq V_{DD} \leq 3.6\text{ V}$ and voltage scaling Range 1
- Fast mode:
 - $2\text{ V} \leq V_{DD} \leq 3.6\text{ V}$ and voltage scaling Range 1 or Range 2.
 - $V_{DD} < 2\text{ V}$, voltage scaling Range 1 or Range 2, $C_{load} < 200\text{ pF}$.

In other ranges, the analog filter should be disabled. The digital filter can be used instead.

Note: In Standard mode, no spike filter is required.

Table 70. I2C analog filter characteristics⁽¹⁾

Symbol	Parameter	Conditions	Min	Max	Unit
t_{AF}	Maximum pulse width of spikes that are suppressed by the analog filter	Range 1	50 ⁽²⁾	100 ⁽³⁾	ns
		Range 2		-	
		Range 3		-	

1. Guaranteed by characterization results.
2. Spikes with widths below $t_{AF(min)}$ are filtered.
3. Spikes with widths above $t_{AF(max)}$ are not filtered

USART/LPUART characteristics

The parameters given in the following table are guaranteed by design.

Table 71. USART/LPUART characteristics

Symbol	Parameter	Conditions	Typ	Max	Unit
$t_{WUUSART}$	Wakeup time needed to calculate the maximum USART/LPUART baudrate allowing to wake up from Stop mode	Stop mode with main regulator in Run mode, Range 2 or 3	-	8.7	μs
		Stop mode with main regulator in Run mode, Range 1	-	8.1	
		Stop mode with main regulator in low-power mode, Range 2 or 3	-	12	
		Stop mode with main regulator in low-power mode, Range 1	-	11.4	

Table 73. SPI characteristics in voltage Range 2 ⁽¹⁾

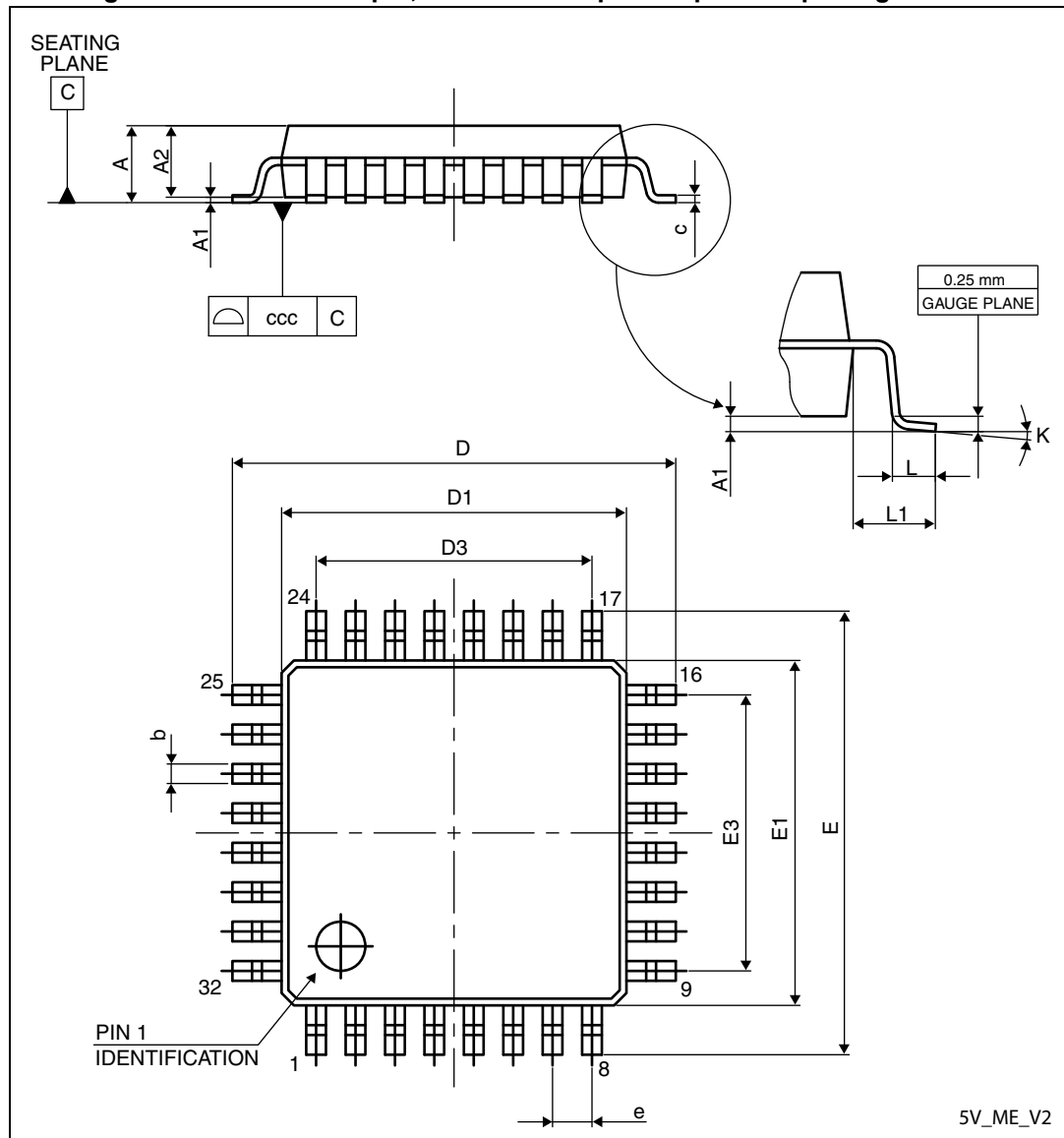
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
f_{SCK} $1/t_{c(SCK)}$	SPI clock frequency	Master mode	-	-	8	MHz
		Slave mode Transmitter $1.65 < V_{DD} < 3.6V$			8	
		Slave mode Transmitter $2.7 < V_{DD} < 3.6V$			8 ⁽²⁾	
$Duty_{(SCK)}$	Duty cycle of SPI clock frequency	Slave mode	30	50	70	%
$t_{su(NSS)}$	NSS setup time	Slave mode, SPI presc = 2	$4 \cdot T_{pclk}$	-	-	ns
$t_{h(NSS)}$	NSS hold time	Slave mode, SPI presc = 2	$2 \cdot T_{pclk}$	-	-	
$t_{w(SCKH)}$ $t_{w(SCKL)}$	SCK high and low time	Master mode	$T_{pclk} - 2$	T_{pclk}	$T_{pclk} + 2$	
$t_{su(MI)}$	Data input setup time	Master mode	0	-	-	
$t_{su(SI)}$		Slave mode	3	-	-	
$t_{h(MI)}$	Data input hold time	Master mode	11	-	-	
$t_{h(SI)}$		Slave mode	4.5	-	-	
$t_{a(SO)}$	Data output access time	Slave mode	18	-	52	
$t_{dis(SO)}$	Data output disable time	Slave mode	12	-	42	
$t_{v(SO)}$	Data output valid time	Slave mode	-	20	56.5	
$t_{v(MO)}$		Master mode	-	5	9	
$t_{h(SO)}$	Data output hold time	Slave mode	13	-	-	
$t_{h(MO)}$		Master mode	3	-	-	

1. Guaranteed by characterization results.

2. The maximum SPI clock frequency in slave transmitter mode is determined by the sum of $t_{v(SO)}$ and $t_{su(MI)}$ which has to fit into SCK low or high phase preceding the SCK sampling edge. This value can be achieved when the SPI communicates with a master having $t_{su(MI)} = 0$ while $Duty_{(SCK)} = 50\%$.

7.2 LQFP32 package information

Figure 36. LQFP32 - 32-pin, 7 x 7 mm low-profile quad flat package outline



1. Drawing is not to scale.

8 Part numbering

Table 83. STM32L082xx ordering information scheme

Example:	STM32	L	082	K	Z	U	6	D	TR
Device family									
STM32 = ARM-based 32-bit microcontroller									
Product type									
L = Low power									
Device subfamily									
082 = USB + AES									
Pin count									
K = 32 pins									
C = 48/49 pins									
Flash memory size									
B = 128 Kbytes									
Z = 192 Kbytes									
Package									
T = LQFP									
U = UFQFPN									
Y = WLCSP pins									
Temperature range									
6 = Industrial temperature range, −40 to 85 °C									
7 = Industrial temperature range, −40 to 105 °C									
3 = Industrial temperature range, −40 to 125 °C									
Options									
No character = V _{DD} range: 1.8 to 3.6 V and BOR enabled									
D = V _{DD} range: 1.65 to 3.6 V and BOR disabled									
Packing									
TR = tape and reel									
No character = tray or tube									

For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST sales office.